

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 09/994,607 | Applicant(s)/Patent Under Reexamination YANAGAWA ET AL. | |
| | Examiner Thang V. Tran | Art Unit 2653 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| | A | US-5,065,380 | 11-1991 | Yokota, Taizo | 369/44.41 |
| | B | US-5,130,963 | 07-1992 | Kusano et al. | 369/44.32 |
| | C | US-5,523,989 | 06-1996 | Ishibashi, Hiromichi | 369/44.32 |
| | D | US-5,751,680 | 05-1998 | Ishibashi et al. | 369/109.01 |
| | E | US-6,141,304 | 10-2000 | Ogasawara, Masakazu | 369/53.19 |
| | F | US-6,594,206 | 07-2003 | Katayama, Ryuichi | 369/44.32 |
| | G | US-6,707,773 | 03-2004 | Katayama, Ryuichi | 369/53.19 |
| | H | US-6,418,104 | 07-2002 | Sato et al. | 369/53.19 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.